

S-5741 Series

HIGH-WITHSTAND VOLTAGE HIGH-SPEED BIPOLAR HALL EFFECT LATCH

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Rev.1.1_01

The S-5741 Series, developed by CMOS technology, is a bipolar Hall effect latch with high-withstand voltage, high-speed detection and high-accuracy magnetic characteristics.

The output voltage changes when the S-5741 Series detects the intensity level of magnetic flux density and a polarity change. Using the S-5741 Series with a magnet makes it possible to detect the rotation status in various devices.

The S-5741 Series includes an output current limit circuit.

High-density mounting is possible by using the small SOT-23-3 package.

Due to its high-accuracy magnetic characteristics, the S-5741 Series can make operation's dispersion in the system combined with magnet smaller.

Caution This product is intended to use in general electronic devices such as consumer electronics, office equipment, and communications devices. Before using the product in medical equipment or automobile equipment including car audio, keyless entry and engine control unit, contact to SII Semiconductor Corporation is indispensable.

■ Features

Pole detection:
 Bipolar latch

• Detection logic for magnetism*1: $V_{OUT} = "L"$ at S pole detection

V_{OUT} = "H" at S pole detection

• Output form*1: Nch open-drain output

Nch driver + built-in pull-up resistor

• Magnetic sensitivity*1: BoP = 1.8 mT typ.

 $B_{OP} = 3.0 \text{ mT typ.}$

 $B_{OP} = 6.0 \text{ mT typ.}$

Operating cycle: t_{CYCLE} = 8.0 μs typ.
 Power supply voltage range: V_{DD} = 3.5 V to 26.0 V

• Built-in regulator

• Built-in output current limit circuit

• Operation temperature range: Ta = -40° C to $+85^{\circ}$ C

• Lead-free (Sn 100%), halogen-free

■ Applications

- Home appliance
- DC brushless motor
- Housing equipment
- Industrial equipment

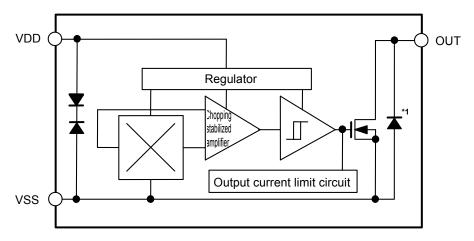
■ Package

• SOT-23-3

^{*1.} The option can be selected.

■ Block Diagrams

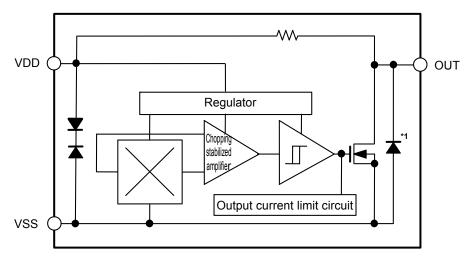
1. Nch open-drain output product



*1. Parasitic diode

Figure 1

2. Nch driver + built-in pull-up resistor product

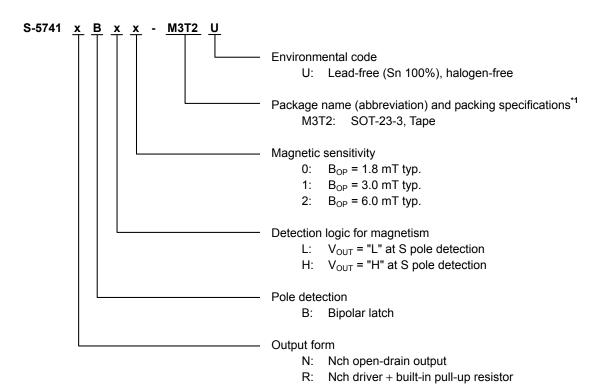


*1. Parasitic diode

Figure 2

■ Product Name Structure

1. Product name



^{*1.} Refer to the tape drawing.

2. Package

Table 1 Package Drawing Codes

Package Name	Dimension	Tape	Reel
SOT-23-3	MP003-C-P-SD	MP003-C-C-SD	MP003-Z-R-SD

3. Product name list

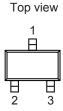
Table 2

Product Name	Output Form	Pole Detection	Detection Logic for Magnetism	Magnetic Sensitivity (B _{OP})
S-5741NBL1-M3T2U	Nch open-drain output	Bipolar latch	V _{OUT} = "L" at S pole detection	3.0 mT typ.
S-5741NBL2-M3T2U	Nch open-drain output	Bipolar latch	V _{OUT} = "L" at S pole detection	6.0 mT typ.
S-5741RBL0-M3T2U	Nch driver + built-in pull-up resistor	Bipolar latch	V _{OUT} = "L" at S pole detection	1.8 mT typ.
S-5741RBL1-M3T2U	Nch driver + built-in pull-up resistor	Bipolar latch	V _{OUT} = "L" at S pole detection	3.0 mT typ.
S-5741RBH1-M3T2U	Nch driver + built-in pull-up resistor	Bipolar latch	V _{OUT} = "H" at S pole detection	3.0 mT typ.

Remark Please contact our sales office for products other than the above.

■ Pin Configuration

1. SOT-23-3



Pin No. Symbol Description

1 VSS GND pin

2 VDD Power supply pin

3 OUT Output pin

Table 3

Figure 3

■ Absolute Maximum Ratings

Table 4

(Ta = +25°C unless otherwise specified)

	Item	Symbol	Absolute Maximum Rating	Unit
Power supply vo	oltage	V_{DD}	$V_{SS} - 0.3$ to $V_{SS} + 28.0$	V
Output current		Іоит 20		
Output valtage	Nch open-drain output product		$V_{SS} - 0.3 \text{ to } V_{SS} + 28.0$	V
Output voltage	Nch driver + built-in pull-up resistor product	Vouт	$V_{SS} - 0.3$ to $V_{DD} + 0.3$	V
Power dissipation		P _D	430*1	mW
Operation ambient temperature		T _{opr}	−40 to +85	°C
Storage tempera	ature	T _{stg}	-40 to +125	°C

^{*1.} When mounted on board

[Mounted board]

(1) Board size: $114.3 \text{ mm} \times 76.2 \text{ mm} \times t1.6 \text{ mm}$ (2) Board name: JEDEC STANDARD51-7

Caution The absolute maximum ratings are rated values exceeding which the product could suffer physical damage. These values must therefore not be exceeded under any conditions.

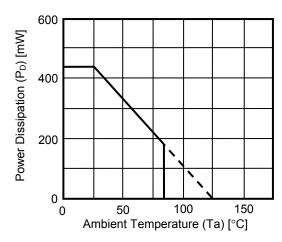


Figure 4 Power Dissipation of Package (When Mounted on Board)

■ Electrical Characteristics

Table 5

(Ta = +25°C, V_{DD} = 12.0 V, V_{SS} = 0 V unless otherwise specified)

Item	Symbol	Condition	Min.	Тур.	Max.	Unit	Test Circuit
Power supply voltage	V_{DD}	-	3.5	12.0	26.0	V	-
Current consumption		Nch open-drain output product Average value	_	3.0	4.0	mA	1
Current consumption	I _{DD}	Nch driver + built-in pull-up resistor product Average value, V _{OUT} = "H"	_	3.0	4.0	mA	1
Output voltage		Nch open-drain output product Output transistor Nch, Vout = "L", Iout = 10 mA		-	0.4	٧	2
	Vout	Nch driver + built-in pull-up resistor product Output transistor Nch, Vout = "L", Iout = 10 mA	_	-	0.5	>	2
Output drop voltage	VD	Nch driver + built-in pull-up resistor product V_{OUT} = "H", V_D = V_{DD} - V_{OUT}	_	_	20	mV	2
Leakage current	I _{LEAK}	Nch open-drain output product Output transistor Nch, V _{OUT} = "H" = 26.0 V	_	-	10	μΑ	3
Operating cycle	tcycle	+	-	8.0	_	μs	_
Operating frequency	fcycle	-	_	125	_	kHz	_
Output limit current	Іом	V _{OUT} = 12.0 V	22	_	70	mA	3
Start up time	t _{PON}	-	_	20	_	μs	4
Pull-up resistor	R∟	Nch driver + built-in pull-up resistor product	7	10	13	kΩ	-

■ Magnetic Characteristics

1. Product with $B_{OP} = 1.8 \text{ mT typ.}$

Table 6

(Ta = +25°C, V_{DD} = 12.0 V, V_{SS} = 0 V unless otherwise specified)

Item		Symbol	Condition	Min.	Тур.	Max.	Unit	Test Circuit
Operation point*1	S pole	Вор	-	0.3	1.8	3.3	mT	4
Release point*2	N pole	B _{RP}	_	-3.3	-1.8	-0.3	mT	4
Hysteresis width*3		B _{HYS}	$B_{HYS} = B_{OP} - B_{RP}$	_	3.6	_	mT	4

2. Product with $B_{OP} = 3.0 \text{ mT typ.}$

Table 7

(Ta = $+25^{\circ}$ C, V_{DD} = 12.0 V, V_{SS} = 0 V unless otherwise specified)

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Item		Symbol	Condition	Min.	Тур.	Max.	Unit	Test Circuit
Operation point*1	S pole	B _{OP}	_	1.5	3.0	4.5	mT	4
Release point*2	N pole	B _{RP}	_	-4.5	-3.0	-1.5	mT	4
Hysteresis width*3	•	B _H ys	B _{HYS} = B _{OP} - B _{RP}	_	6.0	_	mT	4

2. Product with $B_{OP} = 6.0 \text{ mT typ.}$

Table 8

(Ta = +25°C, V_{DD} = 12.0 V, V_{SS} = 0 V unless otherwise specified)

Item		Symbol	Condition	Min.	Тур.	Max.	Unit	Test Circuit
Operation point*1	S pole	Bop	_	3.0	6.0	9.0	mT	4
Release point*2	N pole	B _{RP}	_	-9.0	-6.0	-3.0	mT	4
Hysteresis width*3		B _{HYS}	$B_{HYS} = B_{OP} - B_{RP}$	ı	12.0	ı	mT	4

^{*1.} B_{OP}: Operation point

 B_{OP} is the value of magnetic flux density when the output voltage (V_{OUT}) changes after the magnetic flux density applied to the S-5741 Series by the magnet (S pole) is increased (by moving the magnet closer).

V_{OUT} retains the status until a magnetic flux density of the N pole higher than B_{RP} is applied.

*2. BRP: Release point

 B_{RP} is the value of magnetic flux density when the output voltage (V_{OUT}) changes after the magnetic flux density applied to the S-5741 Series by the magnet (N pole) is increased (by moving the magnet closer).

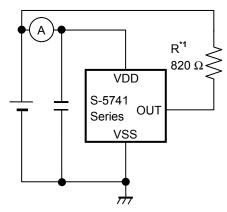
V_{OUT} retains the status until a magnetic flux density of the S pole higher than B_{OP} is applied.

B_{HYS} is the difference of magnetic flux density between B_{OP} and B_{RP}.

Remark The unit of magnetic density mT can be converted by using the formula 1 mT = 10 Gauss.

^{*3.} B_{HYS}: Hysteresis width

■ Test Circuits



*1. Resistor (R) is unnecessary for the pull-up resistor built-in product.

Figure 5 Test Circuit 1

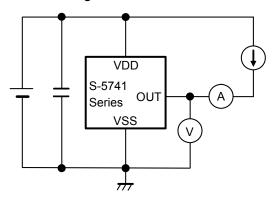


Figure 6 Test Circuit 2

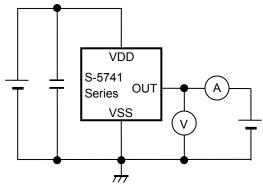
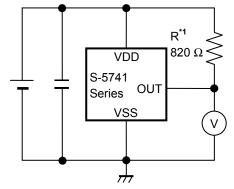


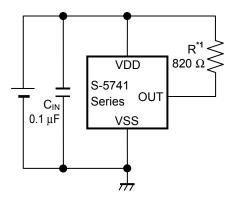
Figure 7 Test Circuit 3



***1.** Resistor (R) is unnecessary for the pull-up resistor built-in product.

Figure 8 Test Circuit 4

■ Standard Circuit



*1. Resistor (R) is unnecessary for the pull-up resistor built-in product.

Figure 9

Caution The above connection diagram and constant will not guarantee successful operation. Perform thorough evaluation using the actual application to set the constant.

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■ Operation

1. Direction of applied magnetic flux

The S-5741 Series detects the magnetic flux density which is vertical to the marking surface. **Figure 10** shows the direction in which magnetic flux is being applied.

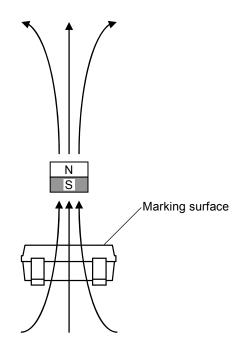


Figure 10

2. Position of Hall sensor

Figure 11 shows the position of Hall sensor.

The center of this Hall sensor is located in the area indicated by a circle, which is in the center of a package as described below.

The following also shows the distance (typ. value) between the marking surface and the chip surface of a package.

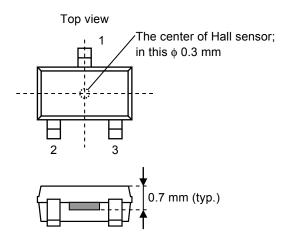


Figure 11

3. Basic operation

The S-5741 Series changes the output voltage (V_{OUT}) according to the level of the magnetic flux density and a polarity change (N pole or S pole) applied by a magnet.

Definition of the magnetic field is performed every operating cycle indicated in "■ Electrical Characteristics".

3. 1 Product with Vout = "L" at S pole detection

When the magnetic flux density of the S pole perpendicular to the marking surface exceeds the operation point (BoP) after the S pole of a magnet is moved closer to the marking surface of the S-5741 Series, V_{OUT} changes from "H" to "L". When the N pole of a magnet is moved closer to the marking surface of the S-5741 Series and the magnetic flux density of the N pole is higher than the release point (BRP), V_{OUT} changes from "L" to "H". In case of BRP < B < BOP, V_{OUT} retains the status. **Figure 12** shows the relationship between the magnetic flux density and V_{OUT} .

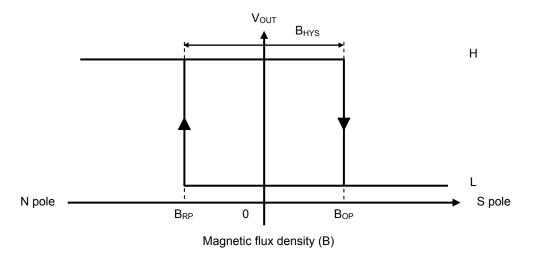


Figure 12

3. 2 Product with V_{OUT} = "H" at S pole detection

When the magnetic flux density of the S pole perpendicular to the marking surface exceeds B_{OP} after the S pole of a magnet is moved closer to the marking surface of the S-5741 Series, V_{OUT} changes from "L" to "H". When the N pole of a magnet is moved closer to the marking surface of the S-5741 Series and the magnetic flux density of the N pole is higher than B_{RP} , V_{OUT} changes from "H" to "L". In case of $B_{RP} < B < B_{OP}$, V_{OUT} retains the status.

Figure 13 shows the relationship between the magnetic flux density and V_{OUT}.

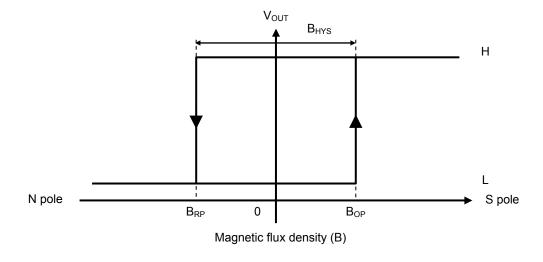


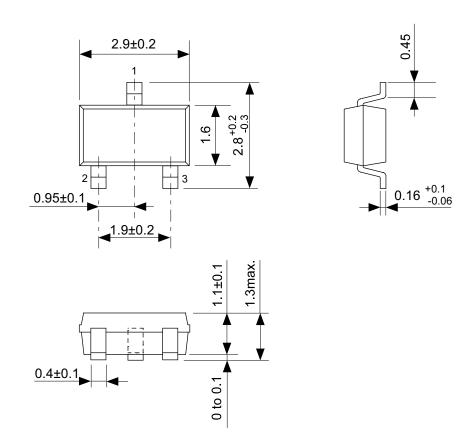
Figure 13

HIGH-WITHSTAND VOLTAGE HIGH-SPEED BIPOLAR HALL EFFECT LATCH

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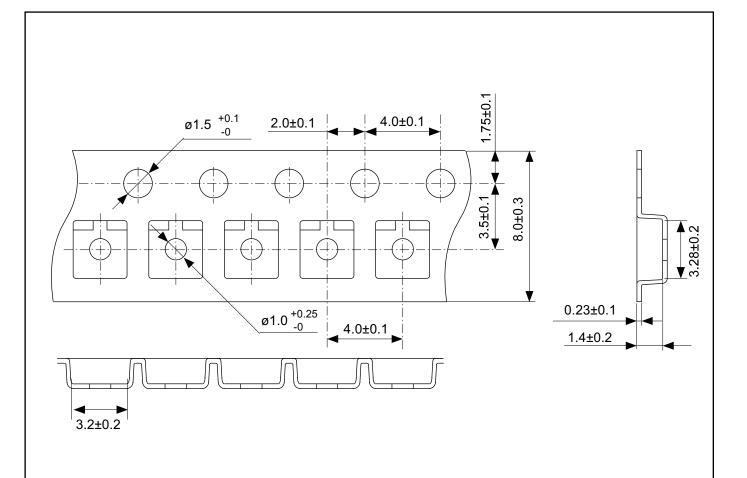
■ Precautions

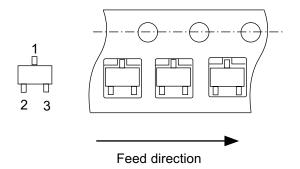
- If the impedance of the power supply is high, the IC may malfunction due to a supply voltage drop caused by feed-through current. Take care with the pattern wiring to ensure that the impedance of the power supply is low.
- Note that the IC may malfunction if the power supply voltage rapidly changes. When the IC is used under the
 environment where the power supply voltage rapidly changes, it is recommended to judge the output voltage of the IC
 by reading it multiple times.
- Do not apply an electrostatic discharge to this IC that exceeds the performance ratings of the built-in electrostatic protection circuit.
- Although this IC has a built-in output current limit circuit, it may suffer physical damage such as product deterioration under the environment where the absolute maximum ratings are exceeded.
- The application conditions for the power supply voltage, the pull-up voltage, and the pull-up resistor should not exceed the package power dissipation.
- Large stress on this IC may affect on the magnetic characteristics. Avoid large stress which is caused by bend and distortion during mounting the IC on a board or handle after mounting.
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No. MP003-C-P-SD-1.1

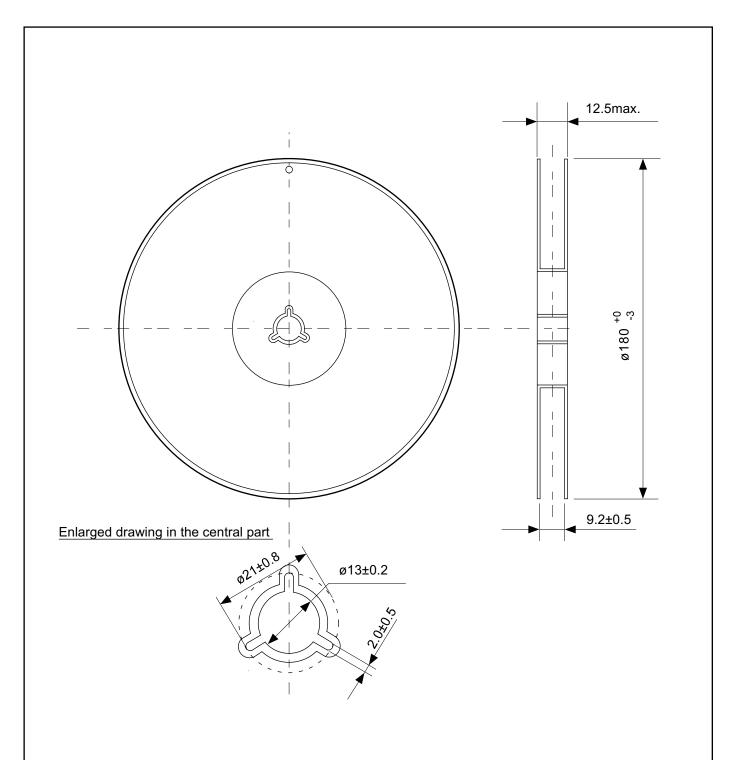
TITLE	SOT233-C-PKG Dimensions			
No.	MP003-C-P-SD-1.1			
ANGLE	\$			
UNIT	mm			
SII Semiconductor Corporation				





No. MP003-C-C-SD-2.0

TITLE	SOT233-C-Carrier Tape			
No.	MP003-C-C-SD-2.0			
ANGLE				
UNIT	mm			
SII Semiconductor Corporation				



No. MP003-Z-R-SD-1.0

TITLE	SOT233-C-Reel						
No.	MP00	MP003-Z-R-SD-1.0					
ANGLE		QTY.	3,000				
UNIT	mm						
SII Semiconductor Corporation							

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